



DIM800XSM45-TS000

Single Switch IGBT Module

DS6089-5 August 2014 (LN31874)

Replaces DS6089-4

FEATURES

- 10µs Short Circuit Withstand
- High Thermal Cycling Capability
- High Current Density Enhanced DMOS SPT
- Isolated AISiC Base With AIN Substrates

APPLICATIONS

- High Reliability Inverters
- Motor Controllers
- Traction Drives
- Choppers

The Powerline range of high power modules includes half bridge, chopper, dual, single and bi-directional switch configurations covering voltages from 1200V to 6500V and currents up to 2400A.

The DIM800XSM45-TS000 is a single switch 4500V, n-channel enhancement mode, insulated gate bipolar transistor (IGBT) module. The IGBT has a wide reverse bias safe operating area (RBSOA) plus 10µs short circuit withstand. This device is optimised for traction drives and other applications requiring high thermal cycling capability.

The module incorporates an electrically isolated base plate and low inductance construction enabling circuit designers to optimise circuit layouts and utilise grounded heat sinks for safety.

ORDERING INFORMATION

Order As:

DIM800XSM45-TS000

Note: When ordering, please use the complete part number

KEY PARAMETERS

V_{CES}		4500V
V _{CE(sat)}	* (typ)	2.7V
l _c ` ´	(max)	A008
I _{C(PK)}	(max)	1600A

^{*} Measured at the auxiliary terminals

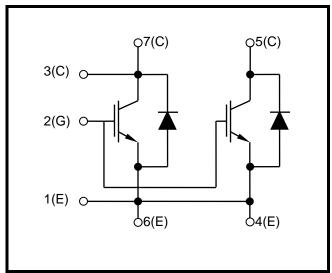


Fig. 1 Circuit configuration



Fig. 2 Package



ABSOLUTE MAXIMUM RATINGS

Stresses above those listed under 'Absolute Maximum Ratings' may cause permanent damage to the device. In extreme conditions, as with all semiconductors, this may include potentially hazardous rupture of the package. Appropriate safety precautions should always be followed. Exposure to Absolute Maximum Ratings may affect device reliability.

T_{case} = 25°C unless stated otherwise

Symbol	Parameter	Test Conditions	Max.	Units
V _{CES}	Collector-emitter voltage	$V_{GE} = 0V$	4500	V
V_{GES}	Gate-emitter voltage		±20	V
I _C	Continuous collector current	T _{case} = 90°C	800	Α
I _{C(PK)}	Peak collector current	1ms, T _{case} = 120°C	1600	Α
P _{max}	Max. transistor power dissipation	T _{case} = 25°C, T _j = 125°C	8.3	kW
l ² t	Diode I ² t value	$V_R = 0$, $t_p = 10$ ms, $T_j = 125$ °C	205	kA ² s
V _{isol}	Isolation voltage – per module	Commoned terminals to base plate. AC RMS, 1 min, 50Hz	7.4	kV
Q_{PD}	Partial discharge – per module	IEC1287, $V_1 = 4800V$, $V_2 = 3500V$, 50Hz RMS	10	рС

THERMAL AND MECHANICAL RATINGS

Internal insulation material:

Baseplate material:

Creepage distance:

Clearance:

CTI (Comparative Tracking Index):

AIN

AISiC

56mm

26mm

>600

Symbol	Parameter	Test Conditions	Min	Тур.	Max	Units
R _{th(j-c)}	Thermal resistance – transistor	Continuous dissipation - junction to case	-	-	12	°C/kW
R _{th(j-c)}	Thermal resistance – diode	Continuous dissipation - junction to case	-	ı	24	°C/kW
R _{th(c-h)}	Thermal resistance – case to heatsink (per module)	Mounting torque 5Nm (with mounting grease)	-	1	8	°C/kW
Tj	Junction temperature	Transistor	-	-	125	°C
		Diode	-	-	125	°C
T _{stg}	Storage temperature range	-	-40	-	125	°C
	Screw torque	Mounting – M6	-	-	5	Nm
		Electrical connections – M4	-	-	2	Nm
		Electrical connections – M8	-	-	10	Nm



ELECTRICAL CHARACTERISTICS

 T_{case} = 25°C unless stated otherwise.

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
	Collector cut-off current	$V_{GE} = 0V$, $V_{CE} = V_{CES}$			1	mA
I _{CES}		$V_{GE} = 0V$, $V_{CE} = V_{CES}$, $T_{case} = 125$ °C			40	mA
I _{GES}	Gate leakage current	$V_{GE} = \pm 20V, V_{CE} = 0V$			1	μΑ
V _{GE(TH)}	Gate threshold voltage	$I_C = 80$ mA, $V_{GE} = V_{CE}$		5.8		V
V	Collector-emitter saturation voltage	V _{GE} = 15V, I _C = 800A		2.7		V
V _{CE(sat)}		V _{GE} = 15V, I _C = 800A, T _j = 125°C		3.5		V
I _F	Diode forward current	DC		800		Α
I _{FM}	Diode maximum forward current	t _p = 1ms		1600		Α
	Diode forward voltage	I _F = 800A		2.8		V
V_{F}		I _F = 800A, T _j = 125°C		3.2		V
C _{ies}	Input capacitance	$V_{CE} = 25V, V_{GE} = 0V, f = 1MHz$		100		nF
Qg	Gate charge	±15V		15		μC
C _{res}	Reverse transfer capacitance	$V_{CE} = 25V, V_{GE} = 0V, f = 1MHz$		TBC		nF
L _M	Module inductance			15		nΗ
R _{INT}	Internal transistor resistance			TBC		μΩ
SC _{Data}	Short circuit current, I _{SC}	$T_{j} = 125^{\circ}\text{C}, \ V_{CC} = 3400\text{V}$ $t_{p} \le 10\mu\text{s}, \ V_{GE} \le 15\text{V}$ $V_{CE \ (max)} = V_{CES} - L^{*}x \ dI/dt$ IEC 60747-9		2400		А

Note:

L is the circuit inductance + L_M



ELECTRICAL CHARACTERISTICS

T_{case} = 25°C unless stated otherwise

Symbol	Parameter	Test Conditions	Min	Тур.	Max	Units
t _{d(off)}	Turn-off delay time			3000		ns
t _f	Fall time	$I_{C} = 800A$ $V_{GF} = \pm 15V$		600		ns
E _{OFF}	Turn-off energy loss	V _{CE} = 2800V		3000		mJ
t _{d(on)}	Turn-on delay time	$R_{G(ON)} = 3.9\Omega$ $R_{G(OFF)} = 3.9\Omega$		900		ns
t _r	Rise time	$C_{ge} = 150 nF$ $L_S \sim 165 nH$		350		ns
E _{ON}	Turn-on energy loss			3200		mJ
Q_{rr}	Diode reverse recovery charge	$I_F = 800A$ $V_{CE} = 2800V$ $dI_F/dt = 1900A/\mu s$		880		μC
I _{rr}	Diode reverse recovery current			680		Α
E _{rec}	Diode reverse recovery energy			1480		mJ

T_{case} = 125°C unless stated otherwise

Symbol	Parameter	Test Conditions	Min	Тур.	Max	Units
t _{d(off)}	Turn-off delay time			3100		ns
t _f	Fall time	$I_{C} = 800A$ $V_{GE} = \pm 15V$		560		ns
E _{OFF}	Turn-off energy loss	V _{CE} = 2800V		3100		mJ
t _{d(on)}	Turn-on delay time	$\begin{array}{c} R_{G(ON)} = 3.9\Omega \\ R_{G(OFF)} = 3.9\Omega \end{array}$		900		ns
t _r	Rise time	C _{ge} = 150nF L _S ~ 165nH		360		ns
E _{ON}	Turn-on energy loss			4300		mJ
Q_{rr}	Diode reverse recovery charge	I _F = 800A		1450		μC
I _{rr}	Diode reverse recovery current	$V_{CE} = 2800V$		750		Α
E _{rec}	Diode reverse recovery energy	dl _F /dt = 2000A/μs		2500		mJ



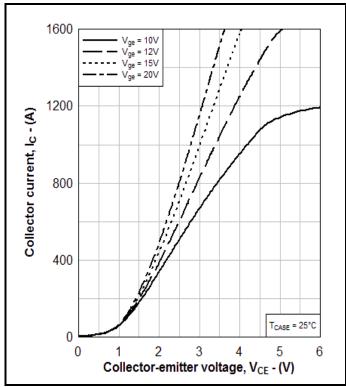


Fig. 3 Typical output characteristics

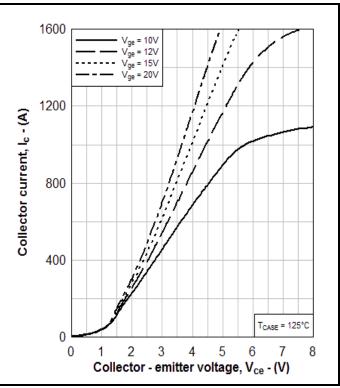


Fig. 4 Typical output characteristics

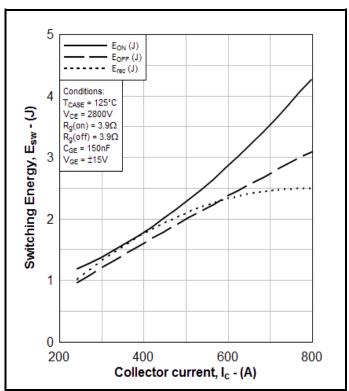


Fig. 5 Typical switching energy vs collector current

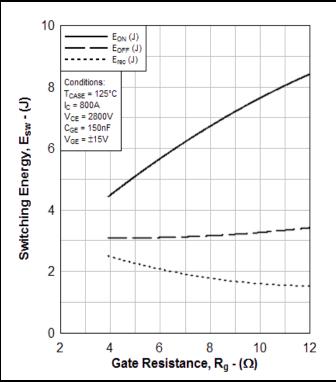


Fig. 6 Typical switching energy vs gate resistance



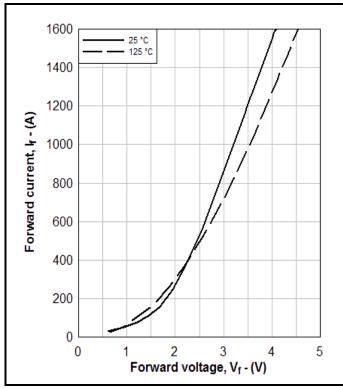


Fig. 7 Diode typical forward characteristics

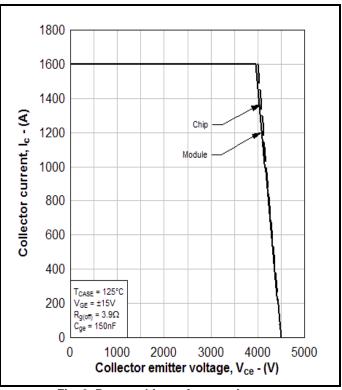


Fig. 8 Reverse bias safe operating area

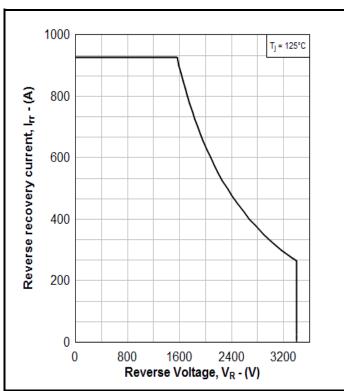


Fig. 9 Diode reverse bias safe operating area

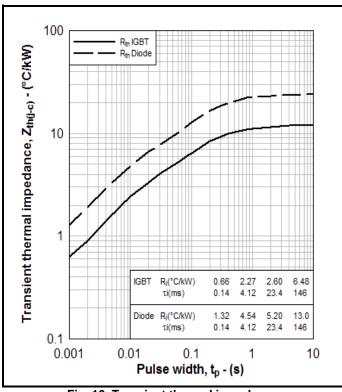


Fig. 10 Transient thermal impedance



PACKAGE DETAILS

For further package information, please visit our website or contact Customer Services. All dimensions in mm, unless stated otherwise.

DO NOT SCALE.

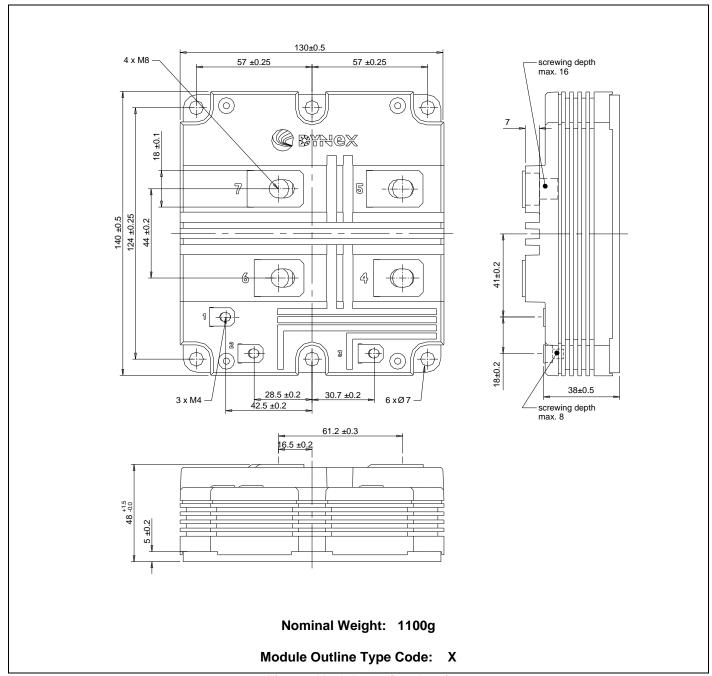


Fig. 11 Module outline drawing



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